Application/Control No.	Applicant(s)/Patent under Reexamination
10/757,840	LUE, VINCENT WEN-JENG
Examiner	Art Unit
Cong-Lac Huynh	2178

SEARCHED					
Class	Subclass	Date	Examiner		
715	513	1/18/2007	CLH		
	514	1/18/2007	CLH		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
		DATE	EXMR	
East		1/18/2007	CLH	
ACM		1/18/2007	CLH	
Google		1/18/2007	CLH	
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